

# TVS Diodes

Transient Voltage Suppressor Diodes

## ESD18VU1B Series

ESD / Transient Protection Diode for Near Field Communication (NFC)

ESD18VU1B-02LRH  
ESD18VU1B-02LS

## Data Sheet

Revision 1.1, 2012-05-30  
Final

**Edition 2012-05-30**

**Published by  
Infineon Technologies AG  
81726 Munich, Germany**

**© 2012 Infineon Technologies AG  
All Rights Reserved.**

### **Legal Disclaimer**

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

### **Information**

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office ([www.infineon.com](http://www.infineon.com)).

### **Warnings**

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

**Revision History: Revision 1.0, 2012-02-09**

Page or Item	Subjects (major changes since previous revision)
<b>Revision 1.1, 2012-05-30</b>	
Page 15	Figure 12 updated

**Trademarks of Infineon Technologies AG**

AURIX™, BlueMoon™, COMNEON™, C166™, CROSSAVE™, CanPAK™, CIPOS™, CoolMOS™, CoolSET™, CORECONTROL™, DAVE™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPACK™, EconoPIM™, EiceDRIVER™, EUPEC™, FCOS™, HITFET™, HybridPACK™, ISOFACE™, I<sup>2</sup>RF™, IsoPACK™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OmniTune™, OptiMOS™, ORIGA™, PROFET™, PRO-SIL™, PRIMARION™, PrimePACK™, RASIC™, ReverSave™, SatRIC™, SIEGET™, SINDRION™, SMARTi™, SmartLEWIS™, TEMPFET™, thinQ!™, TriCore™, TRENCHSTOP™, X-GOLD™, XMM™, X-PMU™, XPOSYS™.

**Other Trademarks**

Advance Design System™ (ADS) of Agilent Technologies, AMBA™, ARM™, MULTI-ICE™, PRIMECELL™, REALVIEW™, THUMB™ of ARM Limited, UK. AUTOSAR™ is licensed by AUTOSAR development partnership. Bluetooth™ of Bluetooth SIG Inc. CAT-iq™ of DECT Forum. COLOSSUS™, FirstGPS™ of Trimble Navigation Ltd. EMV™ of EMVCo, LLC (Visa Holdings Inc.). EPCOS™ of Epcos AG. FLEXGO™ of Microsoft Corporation. FlexRay™ is licensed by FlexRay Consortium. HYPERTERMINAL™ of Hilgraeve Incorporated. IEC™ of Commission Electrotechnique Internationale. IrDA™ of Infrared Data Association Corporation. ISO™ of INTERNATIONAL ORGANIZATION FOR STANDARDIZATION. MATLAB™ of MathWorks, Inc. MAXIM™ of Maxim Integrated Products, Inc. MICROTEC™, NUCLEUS™ of Mentor Graphics Corporation. Mifare™ of NXP. MIPI™ of MIPI Alliance, Inc. MIPS™ of MIPS Technologies, Inc., USA. muRata™ of MURATA MANUFACTURING CO., MICROWAVE OFFICE™ (MWO) of Applied Wave Research Inc., OmniVision™ of OmniVision Technologies, Inc. Openwave™ Openwave Systems Inc. RED HAT™ Red Hat, Inc. RFMD™ RF Micro Devices, Inc. SIRIUS™ of Sirius Sattelite Radio Inc. SOLARIS™ of Sun Microsystems, Inc. SPANSION™ of Spansion LLC Ltd. Symbian™ of Symbian Software Limited. TAIYO YUDEN™ of Taiyo Yuden Co. TEAKLITE™ of CEVA, Inc. TEKTRONIX™ of Tektronix Inc. TOKO™ of TOKO KABUSHIKI KAISHA TA. UNIX™ of X/Open Company Limited. VERILOG™, PALLADIUM™ of Cadence Design Systems, Inc. VLYNQ™ of Texas Instruments Incorporated. VXWORKS™, WIND RIVER™ of WIND RIVER SYSTEMS, INC. ZETEX™ of Diodes Zetex Limited.

Last Trademarks Update 2010-06-09

## Table of Contents

	<b>Table of Contents</b> .....	4
	<b>List of Figures</b> .....	5
	<b>List of Tables</b> .....	6
<b>1</b>	<b>ESD / Transient Protection Diode for Near Field Communication (NFC)</b> .....	7
1.1	Features .....	7
1.2	Application Examples .....	7
<b>2</b>	<b>Product Description</b> .....	7
<b>3</b>	<b>Characteristics</b> .....	8
3.1	Electrical Characteristics at $T_A = 25\text{ °C}$ , unless otherwise specified .....	8
3.2	Typical Characteristics at $T_A = 25\text{ °C}$ , unless otherwise specified .....	10
<b>4</b>	<b>Application Information</b> .....	13
<b>5</b>	<b>Ordering Information Scheme (Examples)</b> .....	14
<b>6</b>	<b>Package Information</b> .....	15
6.1	PG-TSSLP-2-1 [2] .....	15
6.2	PG-TSLP-2-17 [2] .....	16
	<b>References</b> .....	17
	<b>Terminology</b> .....	18

## List of Figures

Figure 1	Pin Configuration and Schematic Diagram .....	7
Figure 2	Definitions of electrical characteristics .....	8
Figure 3	Reverse current: $I_R = f(V_R)$ .....	10
Figure 4	Line capacitance: $C_L = f(V_R), f = 1 \text{ MHz}$ .....	10
Figure 5	IEC61000-4-2 $V_{CL} = f(t)$ , 8 kV positiv pulse from pin 1 to pin 2 .....	11
Figure 6	IEC61000-4-2 $V_{CL} = f(t)$ , 8 kV negativ pulse from pin 1 to pin 2 .....	11
Figure 7	Clamping voltage : $I_{TLP} = f(V_{TLP})$ .....	12
Figure 8	Bi-directional ESD / Transient protection for NFC Frontend <a href="#">[3]</a> .....	13
Figure 9	Ordering information scheme .....	14
Figure 10	PG-TSSLP-2-1: Package overview .....	15
Figure 11	PG-TSSLP-2-1: Footprint .....	15
Figure 12	PG-TSSLP-2-1: Packing .....	15
Figure 13	PG-TSSLP-2-1: Marking (example) .....	15
Figure 14	PG-TSLP-2-17: Package overview .....	16
Figure 15	PG-TSLP-2-17: Footprint .....	16
Figure 16	PG-TSLP-2-17: Packing .....	16
Figure 17	PG-TSLP-2-17: Marking (example) .....	16

## List of Tables

Table 1	Ordering Information . . . . .	7
Table 2	Maximum Rating at $T_A = 25\text{ °C}$ , unless otherwise specified . . . . .	8
Table 3	AC Characteristics at $T_A = 25\text{ °C}$ , unless otherwise specified . . . . .	9
Table 4	RF Characteristics at $T_A = 25\text{ °C}$ , unless otherwise specified . . . . .	9
Table 5	ESD Characteristics at $T_A = 25\text{ °C}$ , unless otherwise specified . . . . .	9

# 1 ESD / Transient Protection Diode for Near Field Communication (NFC)

## 1.1 Features

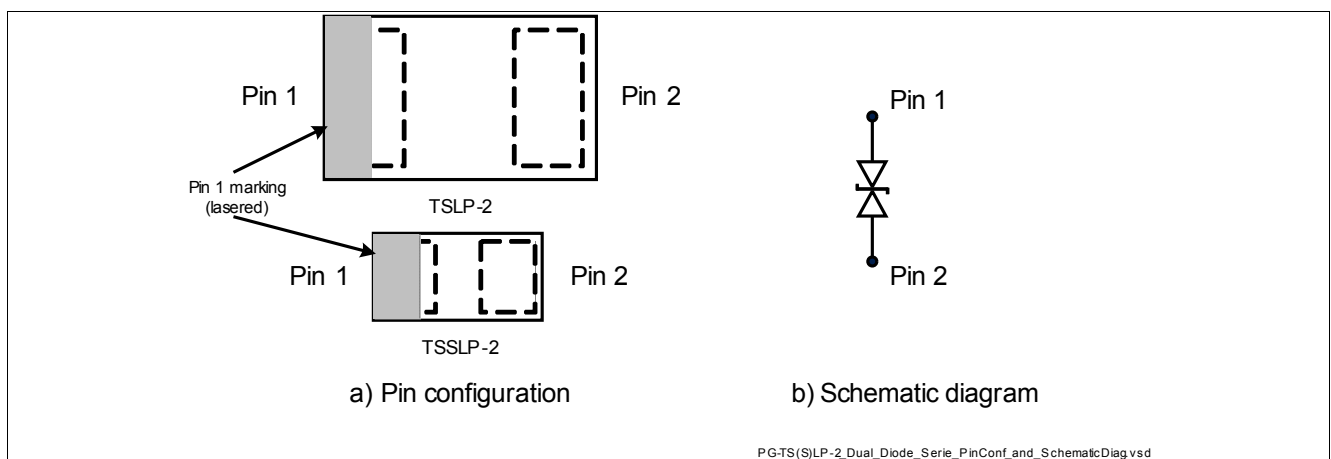
- ESD / transient protection according to:
  - IEC61000-4-2 (ESD contact discharge):  $\pm 10$  kV
  - IEC61000-4-5 (surge): 2 A ( $t_p = 8 / 20 \mu\text{s}$ )
- AC working voltage up to  $\pm 18.5$  V ( $V_{\text{TRIG min}} = 20$  V)
- Ultra-low capacitance:  $C_L = 0.3$  pF (typical)
- Small leadless plastic package, size 0201 / 0402
- Pb-free (RoHS compliant) and halogen free package



## 1.2 Application Examples

- ESD Protection of RF signal lines in Near Field Communication (NFC) applications

# 2 Product Description



**Figure 1 Pin Configuration and Schematic Diagram**

**Table 1 Ordering Information**

Type	Package	Configuration	Marking code
ESD18VU1B-02LRH	PG-TSLP-2-17	1 line, bi-directional	X
ESD18VU1B-02LS	PG-TSSLP-2-1	1 line, bi-directional	X

### 3 Characteristics

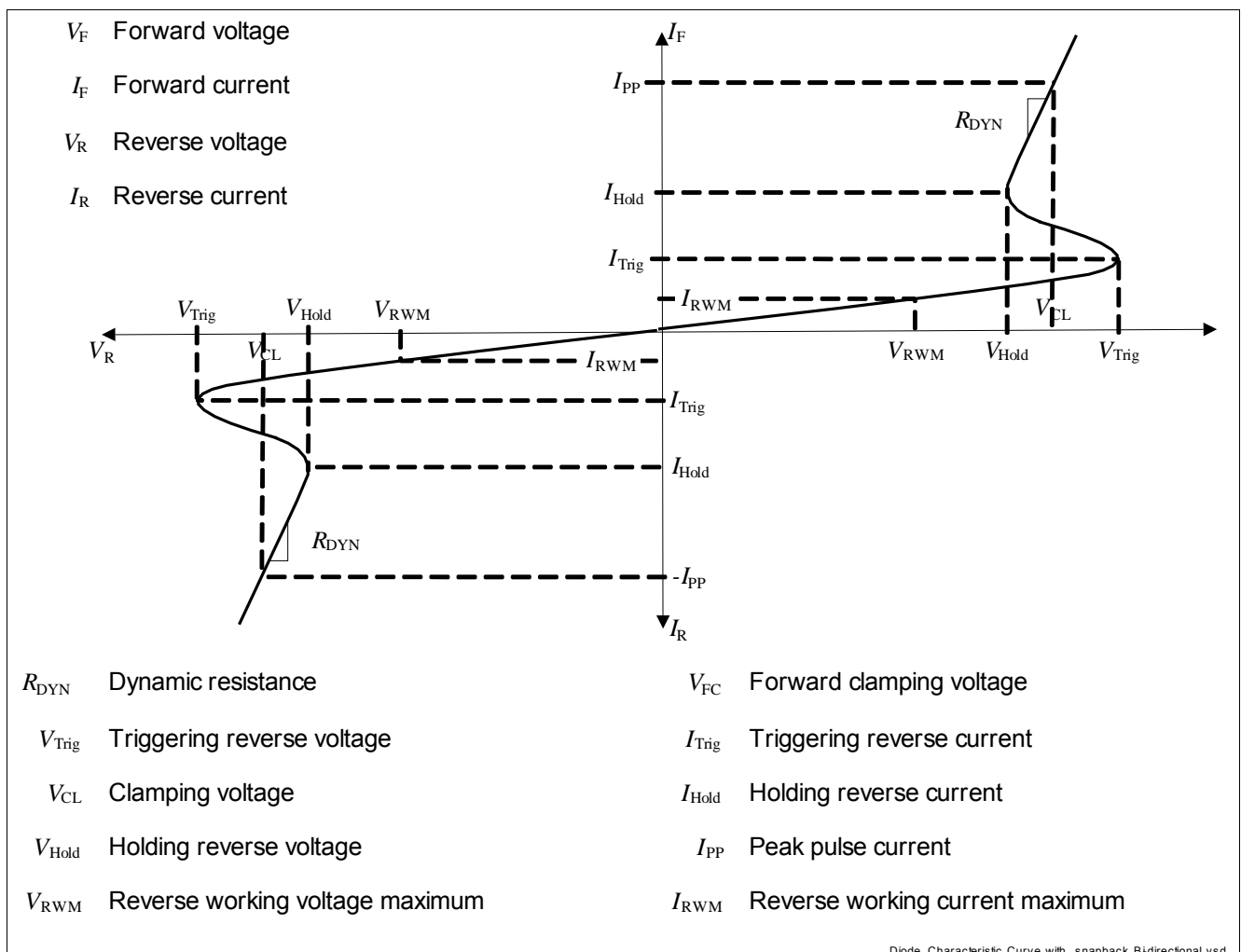
**Table 2** Maximum Rating at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		Min.	Typ.	Max.	
ESD air discharge <sup>1)</sup>	$V_{ESD}$	–	15	–	kV
ESD contact discharge <sup>1)</sup>	$V_{ESD}$	–	–	10	kV
Peak pulse current ( $t_p = 8 / 20\ \mu\text{s}$ ) <sup>2)</sup>	$I_{PP}$	–	–	2	A
Operating temperature	$T_{OP}$	-40	–	85	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-55	–	150	$^\circ\text{C}$

1)  $V_{ESD}$  according to IEC61000-4-2

2)  $I_{PP}$  according to IEC61000-4-5

#### 3.1 Electrical Characteristics at $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified



**Figure 2** Definitions of electrical characteristics



**Table 3 AC Characteristics at  $T_A = 25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
AC working voltage	$V_{RWM}$	–	–	18.5	V	Both directions
AC trigger voltage	$V_{TRIG}$	20	–	–	V	Both directions
AC reverse current	$I_R$	–	–	30	nA	$V_R = 18.5\text{ V}$ Both directions
		–	–	1	mA	$V_R = 20\text{ V}$ Both directions

**Table 4 RF Characteristics at  $T_A = 25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Line capacitance <sup>1)</sup>	$C_L$	–	0.3	0.6	pF	$V_R = 0\text{ V}, f = 1\text{ MHz}$
		–	0.3	0.6	pF	$V_R = 0\text{ V}, f = 1\text{ GHz}$
Serie inductance	$L_S$	–	0.2	–	nH	ESD18VU1B-02LS
		–	0.4	–	nH	ESD18VU1B-02LRH

1) Total capacitance I/O to GND

**Table 5 ESD Characteristics at  $T_A = 25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Clamping voltage <sup>1)</sup>	$V_{CL}$	–	28	–	V	$I_{PP} = 16\text{ A},$ $t_p = 100\text{ ns}$
		–	34	–		$I_{PP} = 25\text{ A},$ $t_p = 100\text{ ns}$
Clamping voltage <sup>2)</sup>	$V_{CL}$	–	17	–	V	$I_{PP} = 1\text{ A},$ $t_p = 8 / 20\text{ }\mu\text{s}$
Dynamic resistance <sup>1)</sup>	$R_{DYN}$	–	0.6	–	$\Omega$	

1) Please refer to Application Note AN210 [1]. TLP parameter:  $Z_0 = 50\text{ }\Omega$ ,  $t_p = 100\text{ ns}$ ,  $t_r = 300\text{ ps}$ , averaging window:  $t_1 = 30\text{ ns}$  to  $t_2 = 60\text{ ns}$ , extraction of dynamic resistance using least squares fit of TLP characteristics between  $I_{PP1} = 10\text{ A}$  and  $I_{PP2} = 40\text{ A}$

2)  $I_{PP}$  according to IEC61000-4-5

3.2 Typical Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified

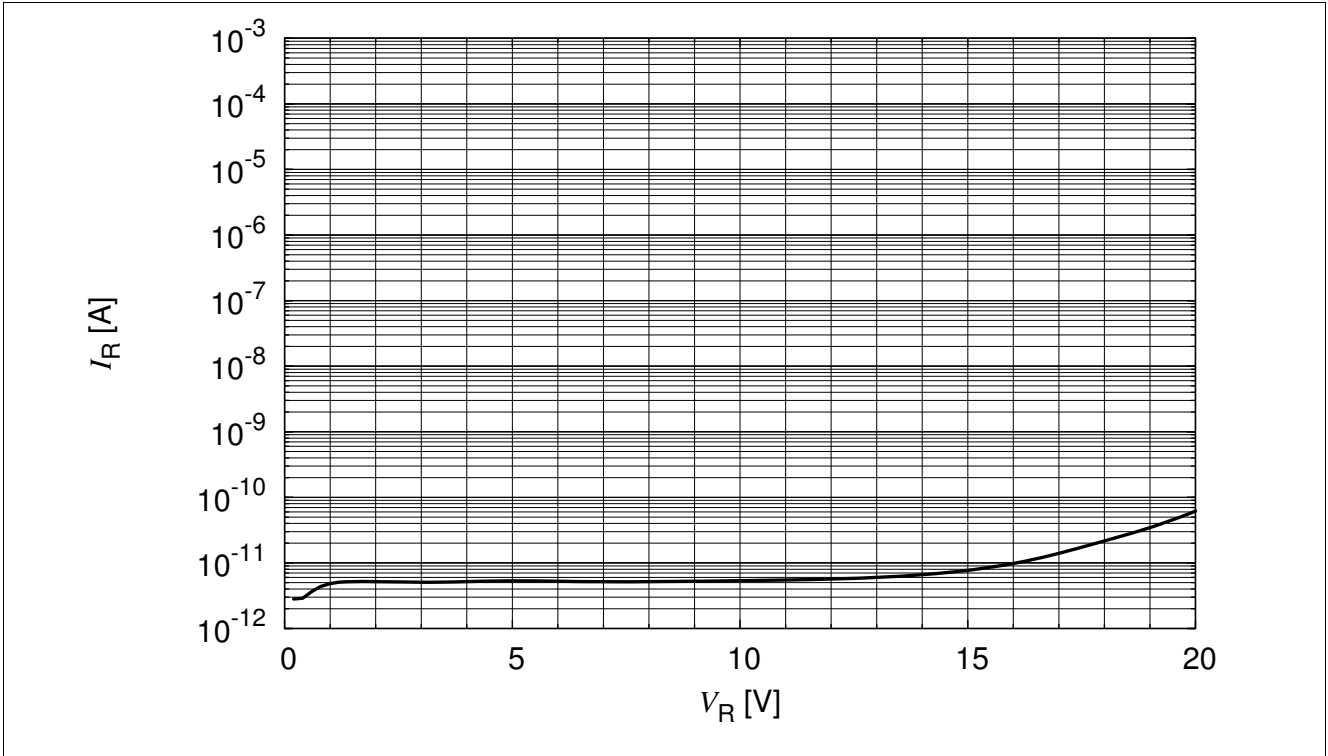


Figure 3 Reverse current:  $I_R = f(V_R)$

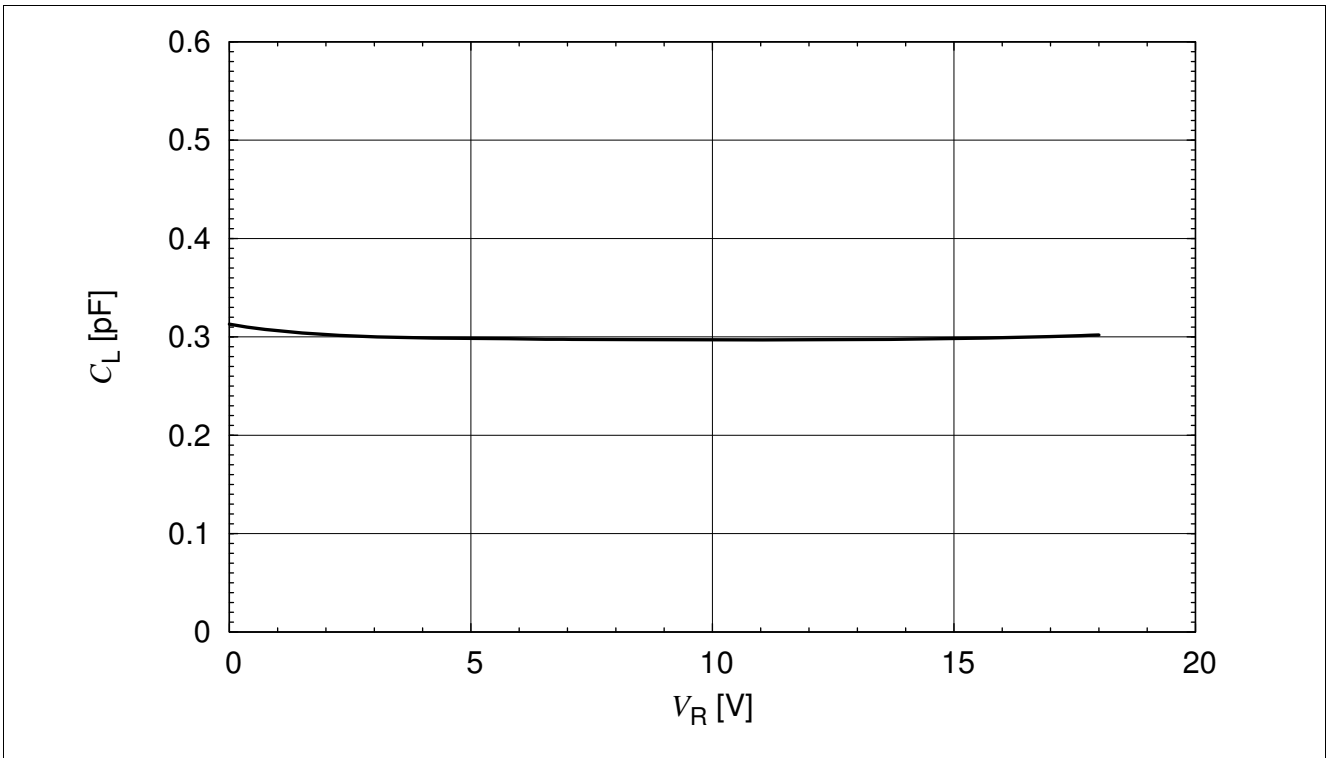


Figure 4 Line capacitance:  $C_L = f(V_R), f = 1\text{ MHz}$

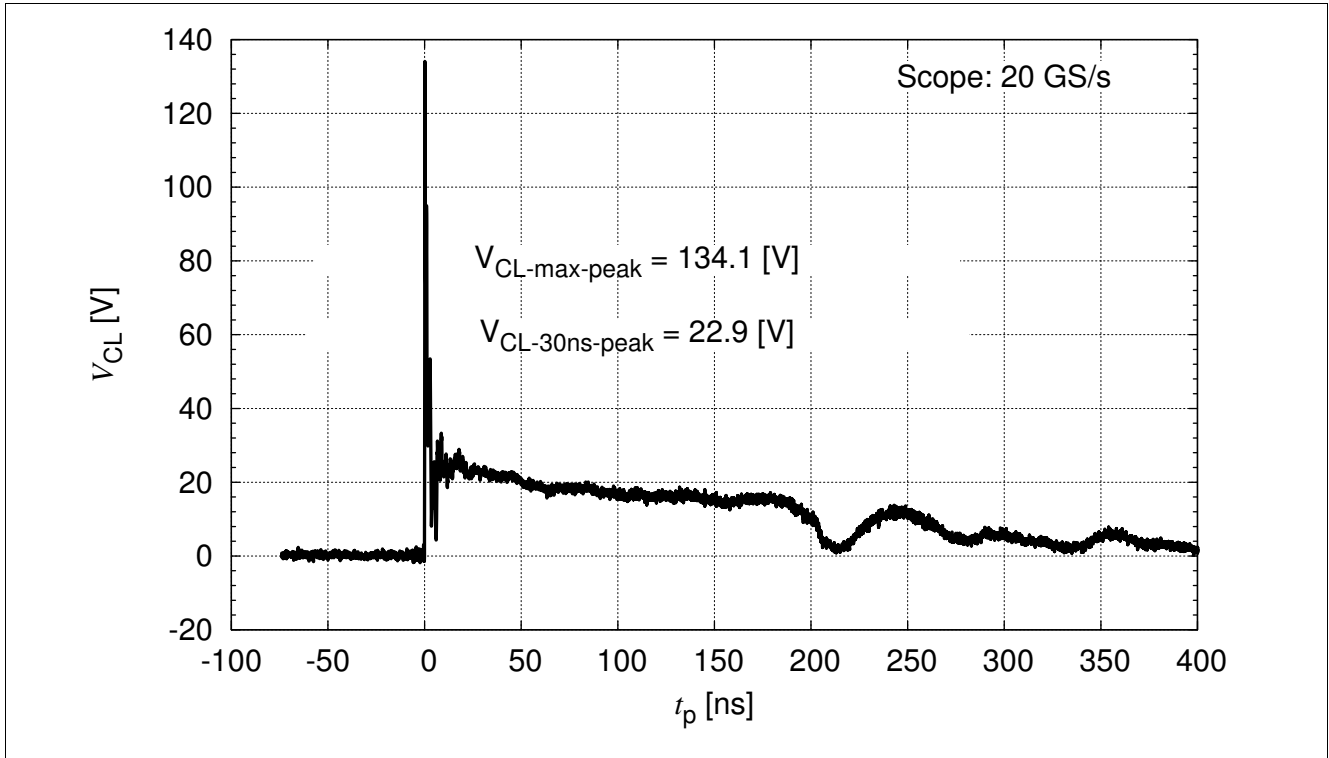


Figure 5 IEC61000-4-2  $V_{CL} = f(t)$ , 8 kV positiv pulse from pin 1 to pin 2

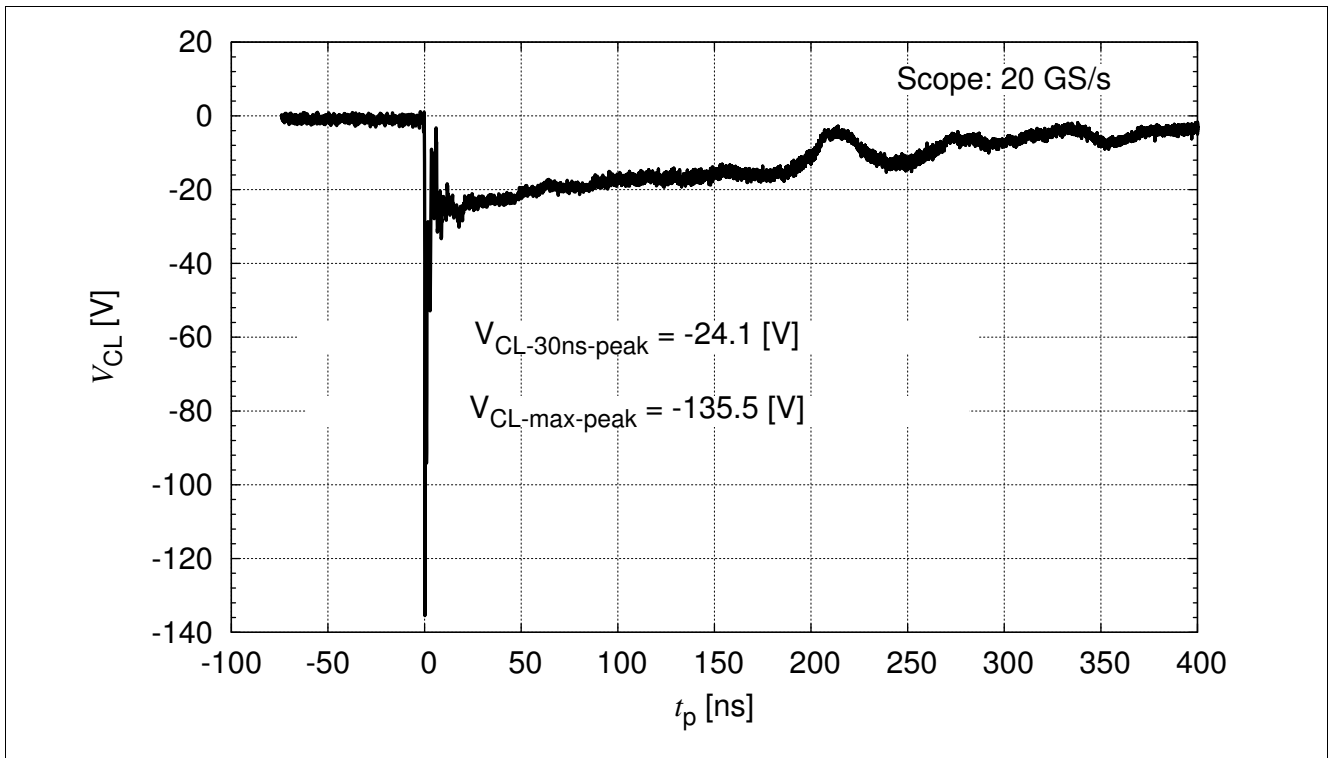


Figure 6 IEC61000-4-2  $V_{CL} = f(t)$ , 8 kV negativ pulse from pin 1 to pin 2

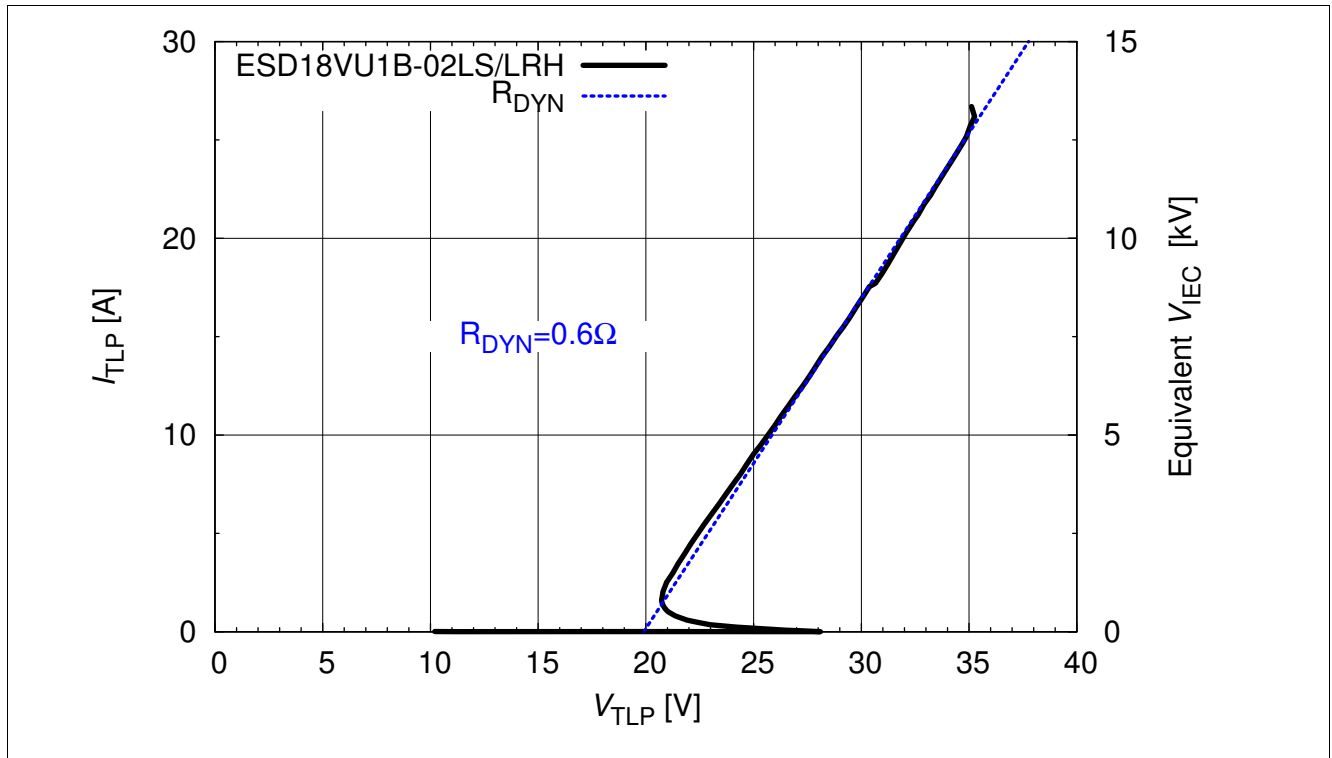


Figure 7 Clamping voltage :  $I_{TLP} = f(V_{TLP})$

4 Application Information

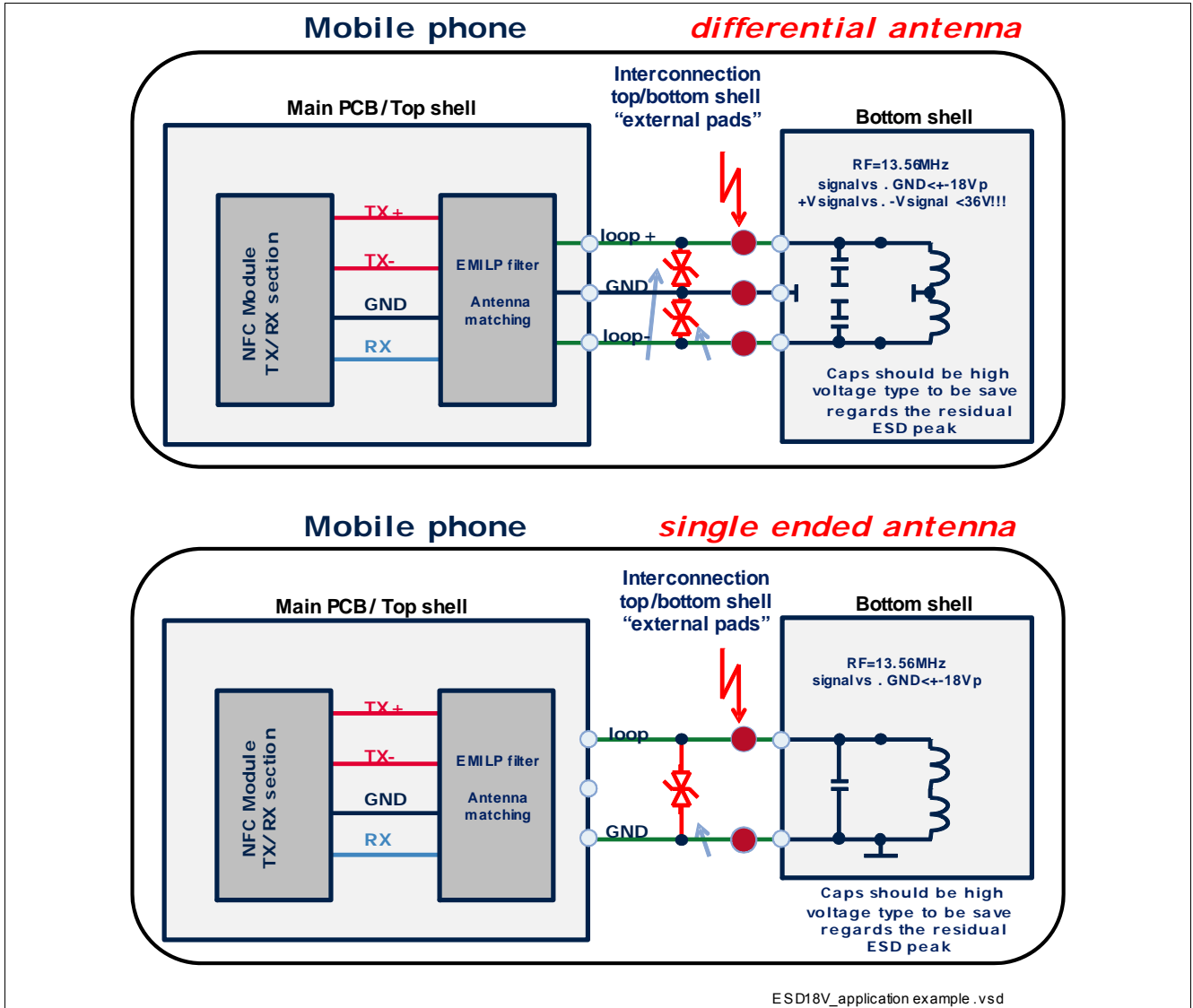


Figure 8 Bi-directional ESD / Transient protection for NFC Frontend [3]

## 5 Ordering Information Scheme (Examples)

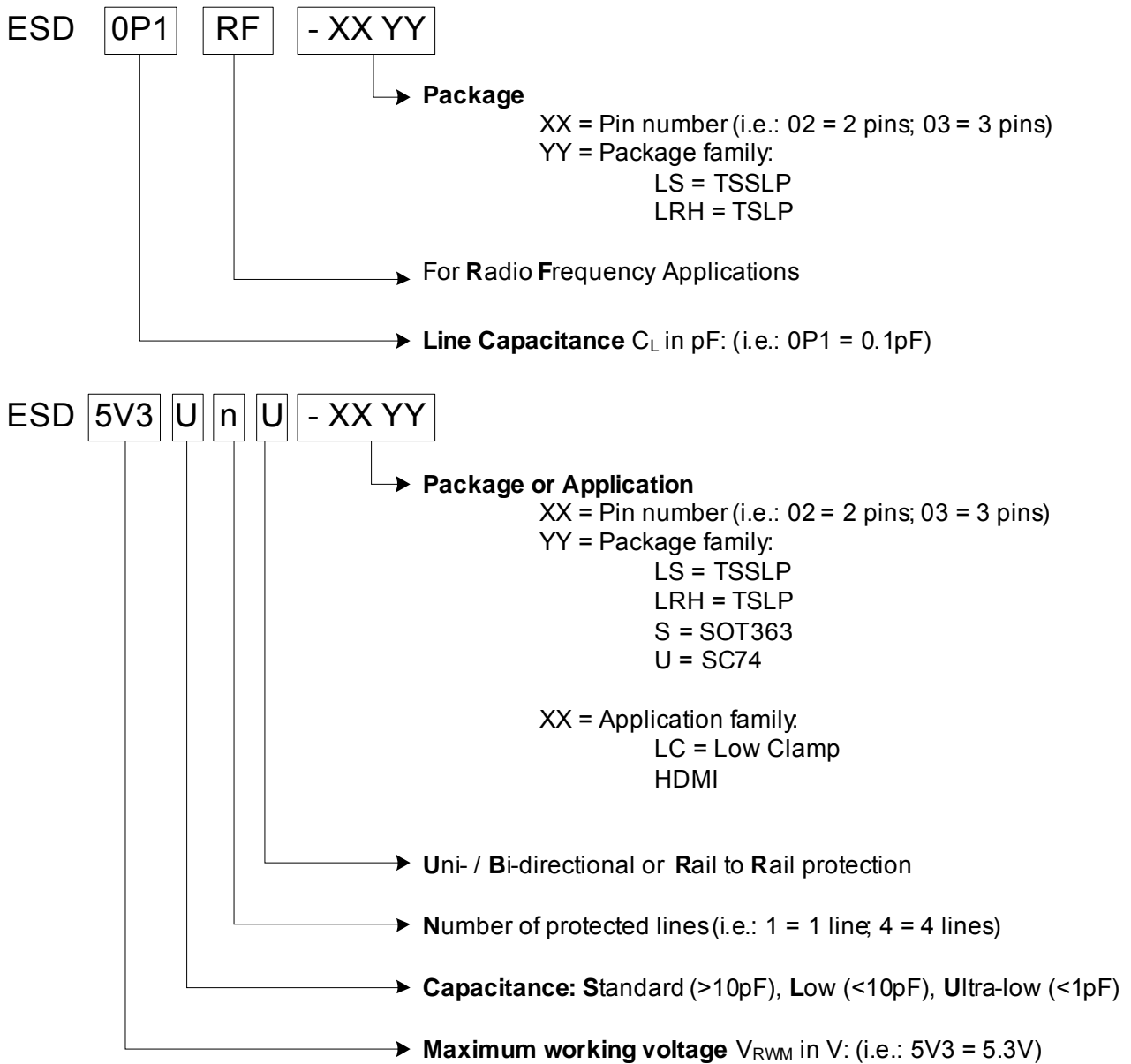


Figure 9 Ordering information scheme

## 6 Package Information

### 6.1 PG-TSSLP-2-1 [2]

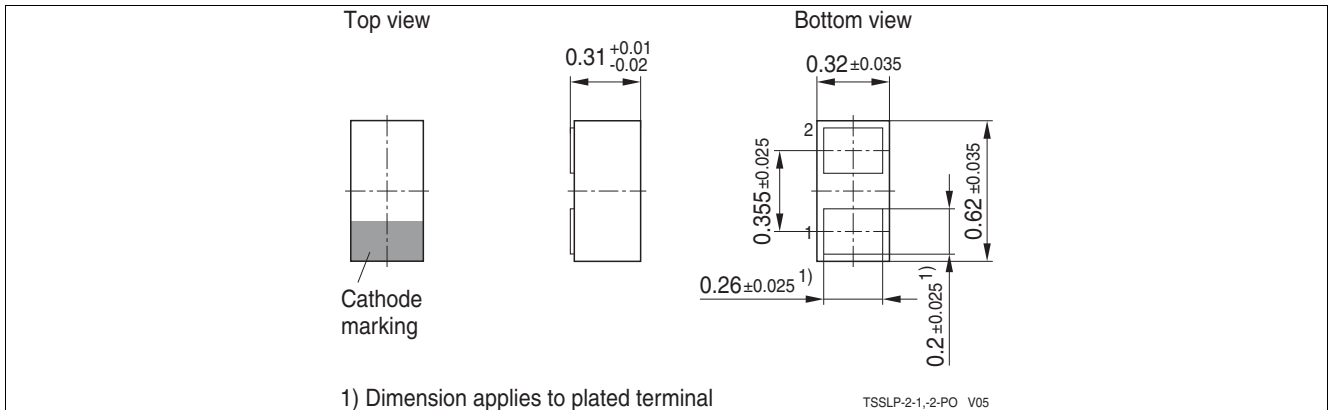


Figure 10 PG-TSSLP-2-1: Package overview

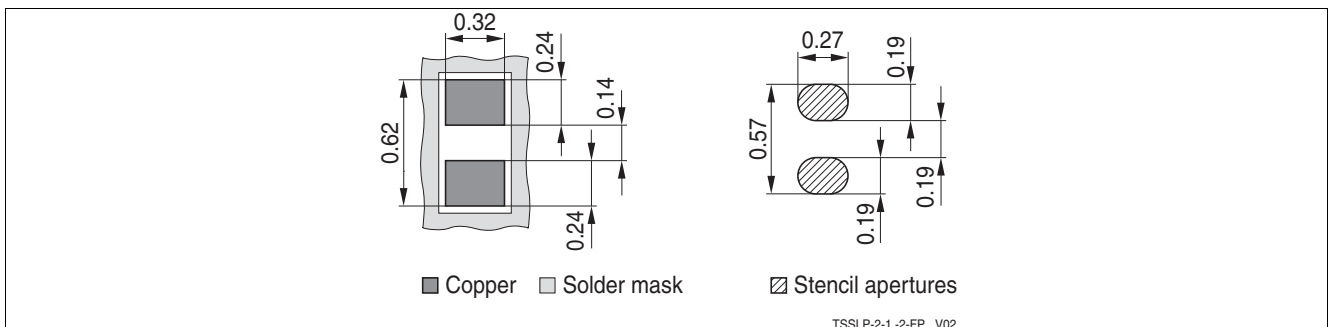


Figure 11 PG-TSSLP-2-1: Footprint

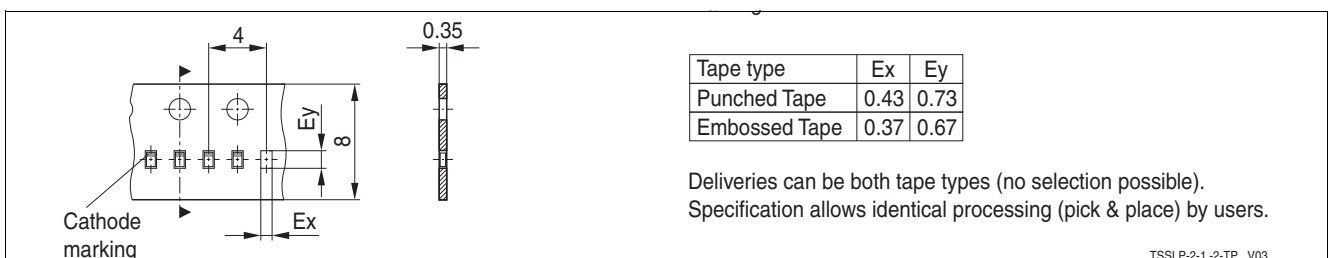


Figure 12 PG-TSSLP-2-1: Packing

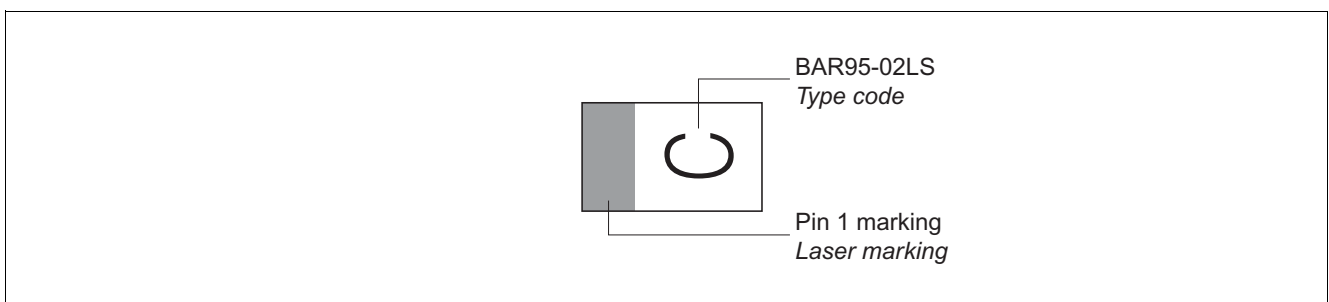


Figure 13 PG-TSSLP-2-1: Marking (example)

6.2 PG-TSLP-2-17 [2]

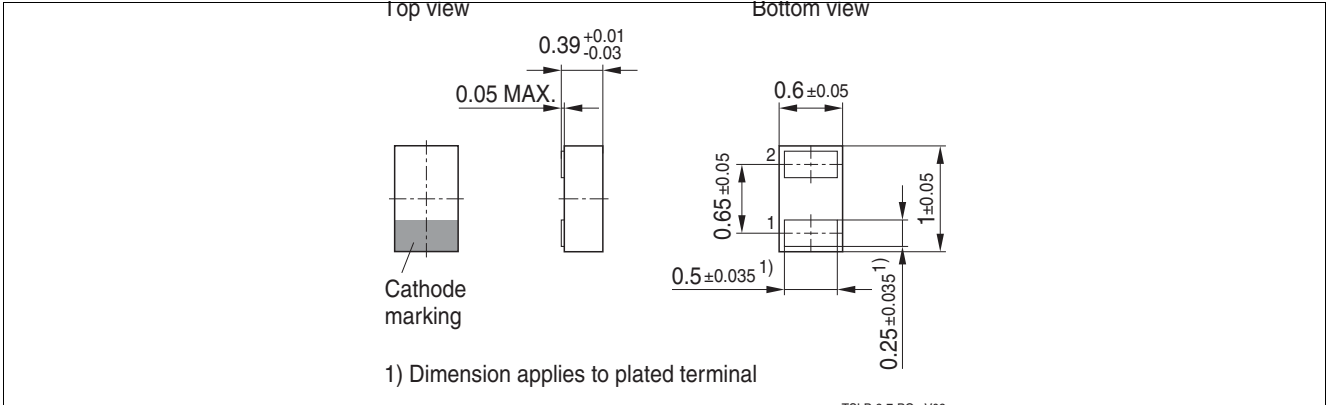


Figure 14 PG-TSLP-2-17: Package overview

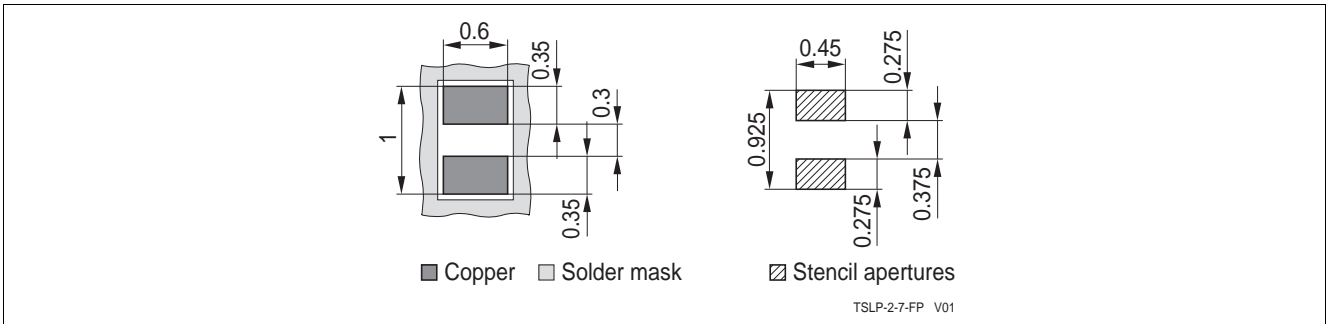


Figure 15 PG-TSLP-2-17: Footprint

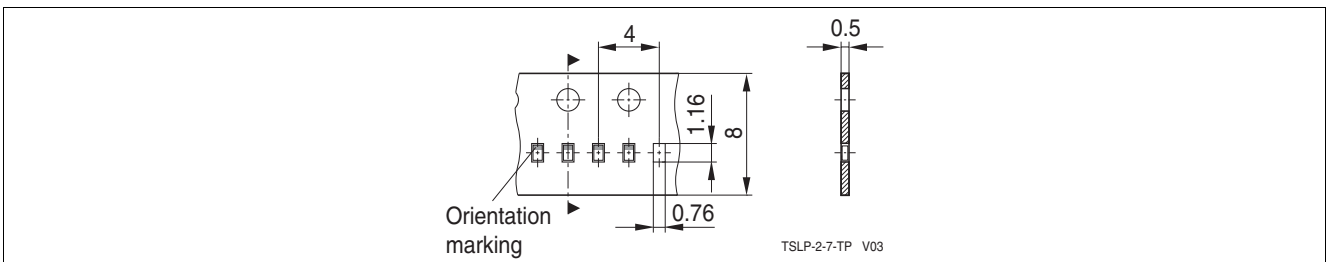


Figure 16 PG-TSLP-2-17: Packing

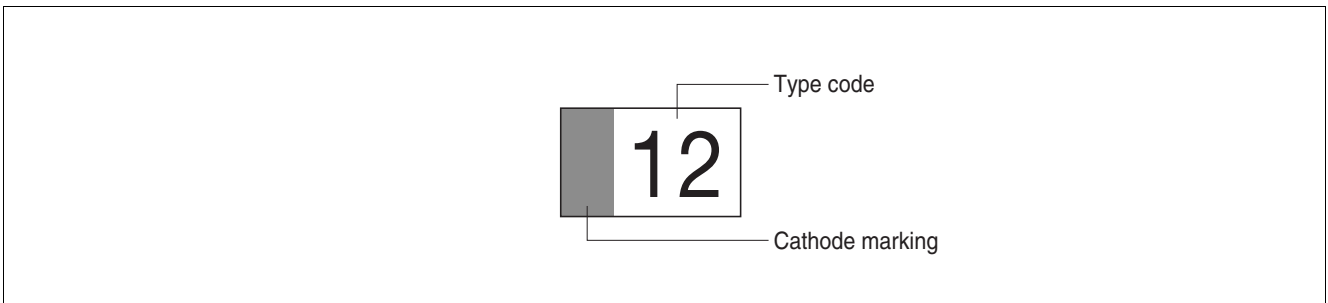


Figure 17 PG-TSLP-2-17: Marking (example)



**References**

- [1] Infineon AG - **Application Note AN210**: Effective ESD Protection design at System Level Using VF-TLP Characterization Methodology
- [2] Infineon AG - Recommendations for PCB Assembly of Infineon TSLP and TSSLP Packages
- [3] Infineon AG - **Application Note AN244**: Tailored ESD Protection for the NFC Frontend

## Terminology

$C_L$	Line capacitance
ESD	Electrostatic Discharge
IEC	International Electrotechnical Commission
$I_{PP}$	Peak pulse current
$I_R$	Reverse current
$I_{RWM}$	Reverse working current maximum
NFC	Near Field Communication
$R_{DYN}$	Dynamic resistance
RoHS	Restriction of Hazardous Substances Directive
$T_A$	Ambient temperature
TLP	Transmission Line Pulse
$T_{OP}$	Operation temperature
$t_p$	Pulse duration
$t_r$	Pulse rise time
$T_{stg}$	Storage temperature
$V_{CL}$	Reverse clamping voltage
$V_{ESD}$	Electrostatic discharge voltage
$V_{FC}$	Forward Clamping Voltage
$V_{IEC}$	Equivalent stress level according IEC61000-4-2 ( $R = 330 \Omega$ , $C = 150 \text{ pF}$ )
$V_R$	Reverse voltage
$V_{RWM}$	Reverse working voltage maximum
$V_{TRIG}$	Trigger voltage
$Z_0$	Impedance

[www.infineon.com](http://www.infineon.com)

Published by Infineon Technologies AG